

Search Notes

Application/Control No.

10/676,017

Examiner

Dennis Cordray

Applicant(s)/Patent under
Reexamination

CHOU ET AL.

Art Unit

1731

SEARCHED

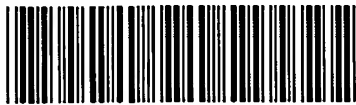
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search - PALM	10/24/2005	DRC
IDS reference search - EAST - see search history printout	10/24/2005	DRC
162/109,111,112,118,119,121,123,12 5,127,129,130,132,141,146,158,157.2 ,157.3,157.4 - cursory	10/24/2005	DRC
162/164.1,164.3,164.6,164.7,166,168. 1,168.2,168.3,168.7,169,173,185,188, 183,197,202,203,204,207,221,224,23 1 - cursory	10/24/2005	DRC
162/270,271,280,281,283,289,290,29 8,301,305,348,361,375,377,903 - cursory	10/24/2005	DRC
156/209,183 264/280,282,283,284 - cursory	10/24/2005	DRC
text search - EAST - see search history printout	10/24/2005	DRC
text search - EAST - see search history printout	10/25/2005	DRC

Search Notes (continued)

Application/Control No.

10/676,017

Examiner

Dennis Cordray

Applicant(s)/Patent under
Reexamination

CHOU ET AL.

Art Unit

1731

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
update text limited search-EAST-see search history printout	5/25/2006	DRC
update text limited search-EAST-see search history printout	1/3/2007	DRC
update search- EAST (US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT)-see search history printout	6/14/2007	DRC
update search- EAST (US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT)-see search history printout	12/4/2007	DRC